Search Notes			

Application/Control	No.

Applicant(s)/Patent under Reexamination

10/728,825 Examiner

AWAI ET AL. Art Unit

Cheukfan Lee

2625

SEARCHED				
Class	Subclass	Date	Examiner	
358	498	2/12/2008	C.L.	
	496			
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner-	
358	498	2/12/2008	C.L.	
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EAST search: mainly image search the classes/subclasses listed left	2/12/2008	C.L.
Inventor search		
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